

**Search Notes**



Application/Control No.

10/070,515

Examiner

CHUONG T. HO

Applicant(s)/Patent under Reexamination

LLOYD ET AL.

Art Unit

2616

SEARCHED			
Class	Subclass	Date	Examiner
370	235	02/03/07	CH
370	254		
709	224		
370	401V		
370	352V		
370	353		
370	231V		
370	235		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
WEST (Text search, Class search)	02/03/07	CH
EAST STN		
IEEE		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner